

Notice of References Cited	Application/Control No. 10/665,312	Applicant(s)/Patent Under Reexamination STUPLE ET AL.	
	Examiner Quoc A. Tran	Art Unit 2176	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0014447 A1	01-2003	White, David J.	707/530
*	B	US-6,580,438 B1	06-2003	Ichimura et al.	715/732
*	C	US-2002/0065852 A1	05-2002	Hendrickson et al.	707/517
*	D	US-2004/0237040 A1	11-2004	Malkin et al.	715/526
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.